

INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)

Docket Number (Optional)
17449

Application Number 10/781999
~~Unassigned~~

Applicant(s)

Shuichi Ohkubo

Filing Date

~~Herewith~~ 2/19/04

Group Art Unit

~~Unassigned~~ 1756

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<u>ALV</u>		07-223372	8/22/95	Japan			X	
<u>ALV</u>		07-104424	4/21/95	Japan			X	
<u>ALV</u>		07-242970	9/8/00	Japan			X	
<u>ALV</u>		2002-293025	10/9/02	Japan			X	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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4/26/07

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INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)				Docket Number (Optional) 17449		Application Number 10/781,999	
				Applicant(s) Shuichi Ohkubo			
				Filing Date February 19, 2004		Group Art Unit 1762-1256	

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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

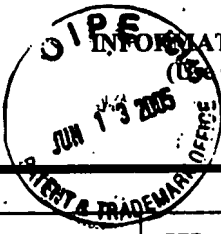
FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
ALV		2003-045085	2/14/03	Japan				
ALV		2002-144736	5/22/02	Japan				
ALV		2003-006860	1/10/03	Japan				
ALV		2002-211137	7/31/02	Japan				
ALV		2002-288876	10/4/02	Japan				
ALV		11-126366	5/11/99	Japan				
ALV		2002-237095	8/23/02	Japan				
ALV		2000-313170	11/14/00	Japan				
ALV		2002-230826	8/16/02	Japan				
ALV		2002-264515	9/18/02	Japan				
ALV		05-016528	1/26/93	Japan				
ALV		02-064929	3/5/90	Japan				

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				Applicant(s) Shuichi Ohkubo				
				Filing Date February 19, 2004		Group Art Unit 1752-1756		
U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
ALW	2001/0036528A1	11/1/01	Abiko et al.					
FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
ALW		01-180387	7/18/89	Japan				
ALW		CN 1320260A	10/31/01	China				
ALW		WO 01/13370 A1	2/22/01	PCT				
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
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				Applicant(s) Shuichi Ohkubo			
				Filing Date February 19, 2004		Group Art Unit 1752 <i>1751</i>	

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>ALV</i>		5,789,055	8/4/1998	Yoon			
<i>ALV</i>		2002/0146643 A1	10/10/2002	Shingai			

FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>ALV</i>		EP 1 172 811 A2	1/16/2002	EPO				
<i>ALV</i>		EP 1 229 530 A2	8/7/2002	EPO				

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